Application/Control No. Applicant(s)/Patent Under Reexamination 09/943,487 EPSHTEYN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1765

Binh X Tran

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,436,302	08-2002	Li et al.	216/38
	В	US-6,395,635	05-2002	Wang et al.	438/692
	С	US-6,343,975	02-2002	Mok, Peter	451/41
	D	US-6,254,454	07-2001	Easter et al.	451/8
	E	US-6,190,234	02-2001	Swedek et al.	451/6
	F	US-			
	G	US-			
	Η	US-			
	-	US-			1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1
	J	US-			
	К	US-			
	L	US-			
	М	US-			

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.